Gate-Tunable Quantum Anomalous Hall Effects in MnBi$_2$Te$_4$ Thin Films

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The quantum anomalous Hall (QAH) effect has recently been realized in thin films of intrinsic magnetic topological insulators (IMTIs) like MnBi$_2$Te$_4$. Here we point out that the QAH gaps of these IMTIs can be optimized, and that both axion insulator/semimetal and Chern insulator/semimetal transitions can be driven by electrical gate fields on the $\sim 10$ meV/nm scale. This effect is described by combining a simplified coupled-Dirac-cone model of multilayer thin films with Schrödinger-Poisson self-consistent-field equations.

Introduction—Following its initial experimental realization in magnetically-doped topological insulators (MTI)\cite{1}, the quantum anomalous Hall (QAH) effect\cite{2} has been widely studied\cite{5,7}. The QAH effect is of interest because of its potential applications in quantum metrology\cite{8,10} and spintronics\cite{11,12}, and because of its potential role as a platform for chiral topological superconductivity\cite{13,14}. Majorana edge modes\cite{15}, and Majorana zero modes\cite{16}. Because of strong disorder, thought to be due mainly to random magnetic dopants, the QAH effect appears only at extremely low temperatures in MTIs. Overcoming this disorder effect has been recognized as key to realizing the higher temperature QAH effects that would bring more applications within reach.

Topological materials with spatially ordered magnetic moments can be realized by forming heterojunctions between ferromagnetic insulators and topological insulators\cite{4} or by growing intrinsic MnBi$_2$X$_4$ or MnSb$_2$X$_4$ magnetic topological insulators (IMTIs) and related superlattices\cite{21,55}, where X=\{Se,Tc\}. The IMTIs consist of seven layers with one magnetic Mn ion in the center and two Te-Bi-Te trilayers outside; Two Dirac cones lie at the surface. (b) Illustration of the coupling between the Dirac cones at the two surfaces of antiferromagnetic MBT thin films. The Dirac-cone masses are produced by exchange coupling to Mn local moments and are opposite in sign for even layer-number thin films and identical for odd-number-layer thin films. (c) Phase diagram of antiferromagnetic thin films, with electric field on the x axis and the number of septuple layers N in the film along the y axis. Different colors represent different phases. The red and blue dashed lines respectively plot the electric fields $E$ at which $eEt_N = E_{gz}$ and $eEt_N/s_{zx} = E_{gz}$, where $E_{gz} \sim 37$ meV is the surface state gap at $E = 0$\cite{21} and $s_{zx} \sim 3.5$ is the perpendicular component of the static dielectric constant of the coupled Dirac cone model.(See main text.)

Our analysis is based on the simplified coupled Dirac-cone model\cite{21} illustrated schematically in Fig. 1(a) and (b)) that captures most topological and electronic properties, and on a self-consistent-field Schödinger-Poisson approximation for the interacting carriers. We show that gates can maximize the QAH gap either by compensating for unintentional electric fields, or in the case of high-Chern-number ferromagnetic (FM) insulators, by tuning

FIG. 1. (a) Crystal structure of one septuple layer of MBT, which consists of seven layers with one magnetic Mn ion in the center and two Te-Bi-Te trilayers outside; Two Dirac cones lie at the surface. (b) Illustration of the coupling between the Dirac cones at the two surfaces of antiferromagnetic MBT thin films. The Dirac-cone masses are produced by exchange coupling to Mn local moments and are opposite in sign for even layer-number thin films and identical for odd-number-layer thin films. (c) Phase diagram of antiferromagnetic thin films, with electric field on the x axis and the number of septuple layers N in the film along the y axis. Different colors represent different phases. The red and blue dashed lines respectively plot the electric fields $E$ at which $eEt_N = E_{gz}$ and $eEt_N/s_{zx} = E_{gz}$, where $E_{gz} \sim 37$ meV is the surface state gap at $E = 0$\cite{21} and $s_{zx} \sim 3.5$ is the perpendicular component of the static dielectric constant of the coupled Dirac cone model.(See main text.)

The quantum anomalous Hall (QAH) effect has recently been realized in thin films of intrinsic magnetic topological insulators (IMTIs) like MnBi$_2$Te$_4$. Here we point out that the QAH gaps of these IMTIs can be optimized, and that both axion insulator/semimetal and Chern insulator/semimetal transitions can be driven by electrical gate fields on the $\sim 10$ meV/nm scale. This effect is described by combining a simplified coupled-Dirac-cone model of multilayer thin films with Schrödinger-Poisson self-consistent-field equations.
the gate field to an optimal non-zero value.

Gate-Field Phase Diagram—The low-energy properties of MBT thin films are accurately modeled by a simple Hamiltonian that includes only Dirac cone surface states on the top and bottom surface of each septuple layer (as illustrated in Fig. 1 (a)), and hopping between Dirac cones:

\[
H = \sum_{\mathbf{k}, \sigma} \left[ \left( -\hbar v_D (\hat{\varepsilon} \times \sigma) \cdot \mathbf{k} + m_i \sigma + V_i \right) \delta_{ij} + \Delta_{ij} (1 - \delta_{ij}) \right] \mathbf{c}_{\mathbf{k}, \sigma}^\dagger \mathbf{c}_{\mathbf{k}, \sigma}.
\]  (1)

Here the Dirac cone labels \(i\) and \(j\) are respectively odd and even on the top and bottom surface of each septuple layer, \(\hbar\) is the reduced Planck’s constant, \(v_D\) is the Dirac-cone velocity and \(V_i\) is the self-consistent Hartree potential on surface \(i\). In the following we retain only the largest Dirac-cone hybridization parameters, letting \(\Delta_{ij} \rightarrow \Delta_S\) for hopping within the same septuple layer and \(\Delta_{ij} \rightarrow \Delta_D\) for hopping across the van der Waals gap between adjacent septuple layers. Exchange interactions between Dirac-cone spins and local moments in the interior of each septuple layer are captured by the mass gap parameter \(m_i = \sum_\alpha J_{i\alpha} M_\alpha\) where \(\alpha\) is a septuple-layer label and \(M_\alpha = \pm 1\) specifies the sense of magnetization on layer \(\alpha\). We include interactions between Dirac cone spins and Mn local moments in the same septuple layer with exchange constant \(J_S\) and with local moments in the closest adjacent layer with exchange constant \(J_D\). In this paper we set \(\Delta_S = 84\) meV, \(\Delta_D = -127\) meV, \(J_S = 36\) meV and \(J_D = 29\) meV, based on the fit to MnBi\(_2\)Te\(_4\) \textit{ab initio} electronic structure calculations discussed in detail in Ref. 21.

The Dirac-cone Hartree potentials \(V_i\) in Eq. 1 are calculated from a discrete Poisson equation in which positions \(z_i\) are assigned to Dirac-cone states ordered sequentially from top to bottom. The position assignments are based on microscopic charge-density-weighted average positions discussed in the Supplementary Material. The discrete Poisson equation reads:

\[
\varepsilon \mathcal{E}_i = \varepsilon \mathcal{E}_i + \sum_{j=1}^{i} \delta \rho_i = \varepsilon \mathcal{E}_{i-1} + \delta \rho_i
\]

\[
V_i = \sum_{j=2}^{i} \mathcal{E}_i(z_i - z_{i-1}) = \mathcal{E}_{i-1} + \mathcal{E}_i(z_i - z_{i-1}).
\]  (2)

Here \(\mathcal{E}_i = \varepsilon_0\) is the electric field controlled by the top gate above the top surface of the thin film, \(\varepsilon_0\) is the electric field between surface \(i\) and \(i+1\), \(\varepsilon\) is intended to account for gate field screening by degrees of freedom not included in our model, and \(V_i\) and \(\delta \rho_i\) are the Hartree-potential and net surface charge density at surface \(i\). (We choose \(V_1 = 0\).)

The bulk perpendicular dielectric constant \(\varepsilon_{zz}\) of MBT has not been measured, to our knowledge, but should be close to \(\varepsilon_{zz} \sim 3\) measured in Bi\(_2\)Te\(_3\) [54]. By calculating the imaginary part of the conductivity of the thin film, \(\sigma_{xx}\), we determine the imaginary part of the conductivity of the thin film, \(\sigma_{xx}\), as in Fig. 1 (c), from which it follows that the thin films become semimetals when the electric field exceeds a critical value. To test the reliability of the simplified electronic structure model in accounting for gate-field response, we performed corresponding DFT calculations of the electron structure of MBT thin film with 2-4 septuple layers. The critical fields using the two approaches are in qualitative agreement.

The critical electric field at which the semimetallic state is reached decreases when the thickness of thin film increases and asymptotically approaches \(E_{gs} \approx t_N / N\), where \(E_{gs} \sim 37\) meV is the surface state energy gap [21] and \(t_N\) the thickness of an \(N\) septuple layer film.
with strong magneto-electric response properties\cite{25}\cite{59}, whereas those with an odd layer-number ($N > 3$) are QAH insulators\cite{21}. This odd-even effect is illustrated schematically in Fig. 1 (b), where it can be seen that the Dirac cones at the top and bottom surfaces have opposite masses for even layer-number, but have identical masses for odd layer-number, this characteristic can be modeled with a effective toy model\cite{57}.

**Gate-control of the QAH effect** — In antiferromagnetic MBT thin films quantized anomalous Hall resistances are expected when the number of septuple layers $N$ is odd. Under these circumstances the film has residual magnetism due to uncompensated moments, and the film is sufficiently thick\cite{21} that coupling between top and bottom surfaces does not induce a transition to a trivial insulator. DFT calculations\cite{41} predict that the QAH effect occurs for three or more layers, and a robust QAH effect has been measured in high-quality five-septuple-layer MBT thin films\cite{37}.

![Figure 2](image)

**FIG. 2.** (a) Gap vs. gate electric field for $N$-septuple layer charge-neutral antiferromagnetic thin films. A negative sign is assigned to the gaps when the Chern number is non-zero. The green shaded regions contain Chern insulator phases while the grey shaded regions contain trivial insulator or semimetal phases (see text). (b) Gap vs. gate electric fields for five-septuple-layer thin films. Neutrality occurs along the yellow dashed line. (c)-(d) Self-consistent bandstructures of neutral five-septuple-layer thin films. In the absence of an electric field bands are labelled as layer symmetric ($s$) or anti-symmetric($a$) and by majority spin ($\uparrow$ or $\downarrow$). Bands at finite electric field are labelled by majority surface ($t$ for top or $b$ for bottom) and majority spin.

In Fig 2 (a) we plot the charge gap of several MBT thin films vs. gate electric field. For even $N$ all insulators are trivial, and gaps decrease with gate fields. The parameters we have chosen for the coupled Dirac–cone model place the $N=3$ thin film on the trivial side of the topological phase transition, but an increase of the magnetic exchange coupling parameters by as little as several meV would drive the system from a trivial insulator state to a Chern insulator state. If the ideal ungated three-septuple layer antiferromagnetic MBT thin film is indeed a trivial insulator, our calculations show that a gate field would not be able to drive the system into a Chern insulator state since the condition to be a Chern insulator is $m > \sqrt{\Delta^2 + V^2}$\cite{57} in the presence of electric field. Here $m, \Delta, V$ are the parameters of mass, hybridization of top and bottom surface states, and Hartree potential induced by the electric field in the toy model illustrated in the supplemental material. On the other hand a small electric field due to asymmetric unintended doping would close the gap of the Chern insulator state\cite{57}, even if it were stable in the ideal case. In contrast odd $N$ films with $N \geq 5$ all have robust QAH effects in the absence of a gate field as shown in Fig. 2 (a)  where we see that gate fields always act to reduce thin film gaps. The ideal QAHE gap cannot be enhanced by gate fields, but dual gating will still be valuable in practice since real samples normally have unintended electric fields for which the gate fields can compensate. This behavior can be understood qualitatively as a consequence of an energetic shift of the magnetically gaped states on one surface relative to those on the other surface, so that the conduction band states of the low-potential energy surface falls below the top of the valence band on the high-potential energy surface. The gaps tend to survive to larger gate electric fields for even $N$ than for odd $N$ because the approaching valence and conduction band extrema states have the same dominant spin in the former case, strengthening level repulsion effects. In the limit of thick films the critical electric field $E$ required to close the gap approaches the value $E_{gs} = \frac{\Delta}{e t_N}$ where $E_{gs} \sim 37$ meV is the energy gap of isolated surface states.

The energy gap in the quasi-2D band structure of the $N = 5$ thin film is plotted vs. top and bottom gate fields in Fig. 2 (b), where the yellow dashed line marks the neutrality line. We see here that as the carrier densities of the films thicken, the overall gap is controlled more and more by independent screening of external electric fields by carriers near either surface. When carriers are present, the screened electric field drops toward near the middle of the films thicken, the overall gap is controlled more and more by independent screening of external electric fields by carriers near either surface. When carriers are present, the screened electric field drops toward near the middle of thick films and larger electric fields are generally required to close the gap. Of course, when the Fermi level does not lie in the gap and away from the neutrality line, the resulting states are magnetically ordered two-dimensional Fermi liquids with large momentum-space Berry curvatures\cite{60}, not Chern insulators. Because these itinerant electron ferromagnets are strongly gate tunable, they are potentially interesting for spintronics.

The band structure evolution with gate field for $N = 5$ neutral antiferromagnets is illustrated in Fig. 2 (c)-(e). In these plots we have labeled the subbands based on the
projection of their densities-of-states to individual spins, and to Dirac cones associated with particular septuple layers. For \( N = 5 \) antiferromagnets the Hamiltonian in the absence of a gate field (Fig. 2(c)) possesses a \( z \rightarrow -z \) mirror symmetry which leads to band eigenstates that are either symmetric \((s)\) or antisymmetric \((a)\) under this symmetry operation. At finite gate fields the four subbands around the Fermi level reside mainly on the top or bottom surfaces (\( t \) for top and \( b \) for bottom) of the thin film and that they are strongly spin-polarized (\( \uparrow \) or \( \downarrow \)). Either \( t \uparrow \) and \( b \downarrow \) or \( t \downarrow \) and \( b \uparrow \) subbands lie close to the Fermi level depending on the direction of the electric field and the spin-configuration. Fig. 2(d) shows the bands near the critical value at which band touching first occurs, near 18 meV/nm for \( \epsilon_{zz} \sim 3.5 \). At larger fields (Fig. 2(e)), the \( b \downarrow \) and \( t \uparrow \) subbands are inverted. The inversion changes the polarizations of the subband just below Fermi level, and drives the thin film from a state with Chern number \( C = 1 \) to semimetal state with \( C = 0 \). In the semimetal state beyond the critical electric field, a small gap reopens in our simplified electron-structure model due to weak-coupling between top and bottom surfaces. These small gaps are not expected to survive the anisotropic band dispersion of more fully realistic models.

**High-Chern-number QAH Systems**—Because their antiferromagnetic interlayer exchange interactions are exceptionally weak, the Mn local moment spins in MBT are aligned by external magnetic fields larger than \( \sim 5 \) Tesla [35, 37, 44]. Since bulk ferromagnetic MBT is a Weyl semimetal, in the thick film limit, the Chern number per layer of a ferromagnetic MBT film approaches the dimensionless Hall conductivity per layer of the bulk semimetal (\( \sim 0.2 \)), with finite-size energy gaps that tend to get smaller as the films get thicker. The Chern number of ferromagnetic MBT thin films with \( N > 8 \) are larger than 1 [28, 44] in the absence of a gate field. In Fig. 3(a) we show the gaps vs. gate electric fields for FM thin films with from with \( N \) from 7 to 10, crossing the thickness at which the Chern number jumps from 1 to 2 at zero electric field. Overall the gaps tend to decrease with gate field as in the antiferromagnetic case. An exception occurs for the \( N = 9 \) and \( N = 10 \) films, for which the gaps initially increase as the system moves further from the \( C = 2 \) to \( C = 1 \) boundary with gate field. In Fig. 3(b), where we assign a positive sign to the gap of odd-Chern-number\((C=1)\) states and a negative sign for even-Chern-number\((C=0 \) or 2) states, we illustrate the thickness dependence for a series of gate fields. Gate electric fields can induce transitions between insulators with different Chern numbers as illustrated in Fig. 3(c).

The green and magenta curves for \( N = 9 \) and \( N = 10 \) in Fig. 3(a) show that the maximum QAH gaps are reached at around 10-15 meV/nm. At around 25 meV/nm, a topological phase transition occurs at which the Chern numbers change from 2 to 1, and further change to 0 as the electric fields increase (shown as in Fig. 3(c)). These transitions are illustrated further in Fig. 3(d) and (e), where we show the bandstructures of FM thin films with \( N = 9 \) in Fig. 3(d) and (e), with zero electric field (red dashed curve in (d)), with electric field \( \mathcal{E} = 15 \) meV/nm (blue curve in (d)), and with electric field \( \mathcal{E} = 25 \) meV/nm (in (e)). Unlike the bandstructures of the AF thin film with \( N = 5 \) in Fig. 2 the bands closest to the Fermi level are not located primarily in the \( t \uparrow \) and \( b \downarrow \) septuple layers and are instead spread across the thin film. As the electric field increases, the \( t \uparrow \) subband is pushed down and the \( b \downarrow \) subbands is pulled up. Before these two subbands touch up at \( \mathcal{E} \sim 25 \) meV/nm (shown in Fig. 3(e)), hybridization between the electron and hole subbands spread across the entire thin film increases and thus increase the QAH gap. When the \( t \uparrow \) and \( b \downarrow \) subbands touch at \( \mathcal{E} \sim 25 \) meV/nm, a topological phase transition occurs at which the Chern number changes from 2 to 1. Similar band inversions occur for the hole subbands which are not shown in the figure, and eventually change the Chern number from 1 to 0.

**Discussion**—In this paper we have focused on neutral MBT thin films. Gate-tuning will be phenomenologically richer in the case of electrostatic doping, where the ground states are expected to be extremely tunable magnetically ordered two-dimensional metals. The Hall effect will remain quantized in doped samples, provided...
that the added charges are localized. Since magnetization textures are charged in Chern insulators, we anticipate the possibility of engineering Skyrmion lattice ground states at finite doping. Separately, gate fields can be used to engineer strong spin-orbit coupling, which is ubiquitous, in Fermi liquid states and to control the interplay between the itinerant electron and Mn local moment contributions to the magnetization.

In summary, we have studied gate tuning effects in MBT thin films using self-consistent Schrödinger-Poisson equations, demonstrating that gates can optimize the QAH gap either by compensating for unintentional electric fields, or in the case of high-Chern-number ferromagnetic (FM) insulators, by tuning the gate field to an optimal non-zero value. Our theory provide an explanation for the absence of the QAH effect in AF thin film textures are charged in Chern insulators, we anticipate the research results reported within this paper.

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Supplementary Material for
"Gate-Tunable Quantum Anomalous Hall Effects in MnBi$_2$Te$_4$ Thin Films"

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DFT calculations

The density functional theory (DFT) calculations were performed using the Vienna Ab initio simulation package (VASP) \cite{S66-S69} using Generalized Gradient Approximation PBE \cite{S70,S71} pseudopotentials. For the plane wave expansion of the DFT calculation we used a cutoff energy of 600 eV, a total electronic energy convergence threshold of $10^{-7}$ eV per unit cell, a $9 \times 9 \times 1$ k mesh is used for self-consistent calculations. A gaussian smearing parameter of 0.05 eV was used to assign partial occupancies.

Discretization of Poisson Equation

The Dirac-cone Hartree potentials $V_i$ in main text are assigned with positions $z_i$ which are based on microscopic charge-density-weighted average positions:

$$z_i = \sum_j w_j z_j$$  \hspace{1cm} (S1)

with $j = \text{Bi, Te}$ and $w_j = p_j / \sum_j p_j$, where $p_j$ is the projected density of states for Bi and Te atoms besides Mn ion (shown in Fig. [S1] for 3-6 septuple layers MBT) got from density-functional-theory.

Calculation of bulk dielectric constant

The bulk dielectric constant is calculated based on the optical conductivity:

$$\epsilon_{zz} = \lim_{\omega \rightarrow 0} (1 + 4i\pi \frac{\partial \sigma_{zz}}{\partial \omega}),$$  \hspace{1cm} (S2)

with the optical conductivity as:

$$\sigma_{zz}(\omega) = \frac{ie^2}{\hbar} \int \frac{dk}{(2\pi)^3} \sum_{nm} f_{nk} - f_{mk} \frac{\langle \psi_{mk} | \partial_z H_k | \psi_{nk} \rangle \langle \psi_{nk} | \partial_z H_k | \psi_{mk} \rangle}{E_{nk} - E_{mk} - (\hbar\omega + i\eta)},$$  \hspace{1cm} (S3)

where $\omega$ is the frequency and $f_{nk}$ is the Fermi-Dirac function.

Trilayer MBT thin film

A topological phase transition happens at $J_S \approx 39 \text{ meV}$ for the N=3 thin film in the coupled Dirac-cone model, the parameters we have chosen place the thin film on the trivial side, in Fig. [S2] we see that the electric field required to drive the N=3 thin film depends on the value of $J_S$, and a small electric field would destroy the Chern insulator state when the film is a Chern insulator.

Charge distribution

Fig. ?? are the charge distribution at the neutrality points for antiferromagnetic MBT thin films, with the total charge density to be 0 and the two surfaces of thin films are electrically polarized.

The electric field distributions across the antiferromagnetic MBT thin films are shown in Fig. [S4] (a)-(d) are showing the cases with thickness from 3 to 6 septuples.

Due to the screening, the electric fields inside the thin films decrease. In Fig. [S5] we estimate the effective dielectric constants with the methods as follow:

$$\epsilon_{eff} = \frac{E_t \times d \times N}{V_b - V_t},$$  \hspace{1cm} (S4)

where $E_t$ is the electric field at the top surface, $V_{t/b}$ is the Hartree potential at the top/bottom surface, and $d$ is the thickness of the thin films.
FIG. S1. Projected density of states of antiferromagnetic MnBi$_2$Te$_4$ thin films with thickness of 3-6 septuple layers. The green solid vertical lines are labeling the outer Te atoms of each septuple layers, while the magenta dashed lines are the weighted location of each Dirac cones.

**Gap vs. Electric Field**

The gaps at Γ points from both DFT calculations and the couple Dirac cone model are shown in Fig. S6. (a) and (b) are the case from DFT calculations while (c) and (d) are got from the couple Dirac cone model. In these plots we assign a minus sign for the thin films with Chern number of 1.

**Toy model for even-odd effect in AF thin films**

The antiferromagnetic MBT thin films may be modeled by a toy model, thin films with odd and even number of layers may be modeled by a topological insulator thin film with the same mass and opposite mass term within the Dirac cone at the two surface.

For MBT thin films with odd number of layers, the two surface Dirac cones have the same mass term, the
effective Hamiltonian in the absence of electric fields is:

\[ H_{\text{odd}} = \begin{pmatrix} m & v_D k^+ & \Delta & 0 \\ v_D k^- & -m & 0 & \Delta \\ \Delta & 0 & m & -v_D k^+ \\ 0 & \Delta & -v_D k^- & -m \end{pmatrix} \] \hspace{1cm} (S5)

where \( k^\pm = k_x \pm ik_y \), \( v_D \) is the Dirac velocity, \( \Delta \) is the hybridization of the two Dirac-cone at the surface and \( m \) is the mass. \( \Delta \) is the effective hybridization which may be got from the parameters \( \Delta_S \) and \( \Delta_D \) in the main text, and \( m \) may be approximately only dependent on \( J_S \). The eigenvalues are:

\[ E = \pm \sqrt{v_D^2 |k|^2 + (m \pm \Delta)^2}, \] \hspace{1cm} (S6)
where $|k| = \sqrt{k_x^2 + k_y^2}$. In the presence of electric field, a perturbation Hamiltonian may be modeled as:

$$V_H = \begin{pmatrix} V & 0 & 0 & 0 \\ 0 & V & 0 & 0 \\ 0 & 0 & -V & 0 \\ 0 & 0 & 0 & -V \end{pmatrix}, \quad (S7)$$

with $\pm V$ the Hartree potential due to the presence of electric field.

For MBT with even number of layers, the effective Hamiltonian in the absence of electric field is:

$$H_{\text{even}} = \begin{pmatrix} m & v_D k^+ & \Delta & 0 \\ v_D k^- & -m & 0 & \Delta \\ \Delta & 0 & -m & -v_D k^+ \\ 0 & \Delta & -v_D k^- & m \end{pmatrix}, \quad (S8)$$

in which the two Dirac cones at the two surfaces have opposite mass. The eigenvalues are:

$$E = \pm \sqrt{v_D^2 |k|^2 + m^2 + \Delta^2}, \quad (S9)$$

### Phase transition vs. electric field

The topological phase transition point may be got via the band energy at $\Gamma$ point, for MBT thin films with odd number of layers, the eigenvalues at $\Gamma$ point are:

$$E = \pm m \pm \sqrt{\Delta^2 + V^2}, \quad (S10)$$

where $V$ is the Hartree potential caused by the electric field. In the absent of electric field, the thin films are in topological phase when $m > \Delta$. In the presence of electric field, this condition becomes as $m > \sqrt{\Delta^2 + V^2}$, which means the exchange interaction needed to induce a topological phase transition is larger and increase with the increase of electric field. While for MBT thin films with even number of layers, the eigenvalues at $\Gamma$ point are:

$$E = \pm \sqrt{(m \pm V)^2 + \Delta^2}, \quad (S11)$$

in this case the there is still no topological phase transition, similar with the case in the absent of electric field.